

Search Notes**Application/Control No.**

10/535,423

Examiner

EDMUND H. LEE

**Applicant(s)/Patent under
Reexamination**

OKAHARA ET AL.

Art Unit

1791

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated	6/19/2010	EHL